GD30MPS12-CAL
1200V 30A SiC Schottky MPS™ Diode

Silicon Carbide Schottky Diode

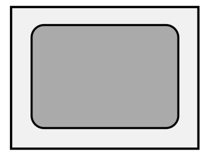
For physical chip dimensions please contact engineering@diedevices.com

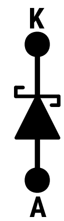
V_{RRM}	=	1200 V
$I_{F\,(T_C = 148°C)}$	=	30 A
Q_C	=	97 nC

Features

- Gen4 Thin Chip Technology for Low V_F
- Superior Figure of Merit Q_C*V_F
- Industry-Leading Avalanche (UIL) Robustness
- Enhanced Surge Current Withstand Capability
- Temperature Independent Fast Switching
- Low Thermal Resistance
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness

Bare Chip





Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- Power Factor Correction (PFC)
- Electric Vehicles and Battery Chargers
- Solar Inverters
- High Frequency Converters
- Switched Mode Power Supply (SMPS)
- Motor Drives
- Anti-Parallel / Free-Wheeling Diode
- Induction Heating & Welding

Absolute Maximum Ratings (At T_C = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V_{RRM}		1200	V	
Continuous Forward Current	I_F	T_C = 100°C, D = 1	55	A	Fig. 4
		T_C = 135°C, D = 1	38		
		T_C = 148°C, D = 1	30		
Non-Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,SM}$	T_C = 25°C, t_P = 10 ms	180	A	
		T_C = 150°C, t_P = 10 ms	30		
Repetitive Peak Forward Surge Current, Half Sine Wave	$I_{F,RM}$	T_C = 25°C, t_P = 10 ms	60	A	
		T_C = 150°C, t_P = 10 ms	30		
Non-Repetitive Peak Forward Surge Current	$I_{F,MAX}$	T_C = 25°C, t_P = 10 µs	120	A	
i^2t Value	$\int i^2dt$	T_C = 25°C, t_P = 10 ms	162	A^2s	
Non-Repetitive Avalanche Energy	E_{AS}	L = 0.6 mH, I_{AS} = 30 A	271	mJ	
Diode Ruggedness	dV/dt	V_R = 0 ~ 960 V	200	V/ns	
Power Dissipation	P_{TOT}	T_C = 25°C	313	W	Fig. 3
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C	

Note 1: Assumes Thermal Resistance, Junction - Case (R_{thJC}) of 0.48°C/W

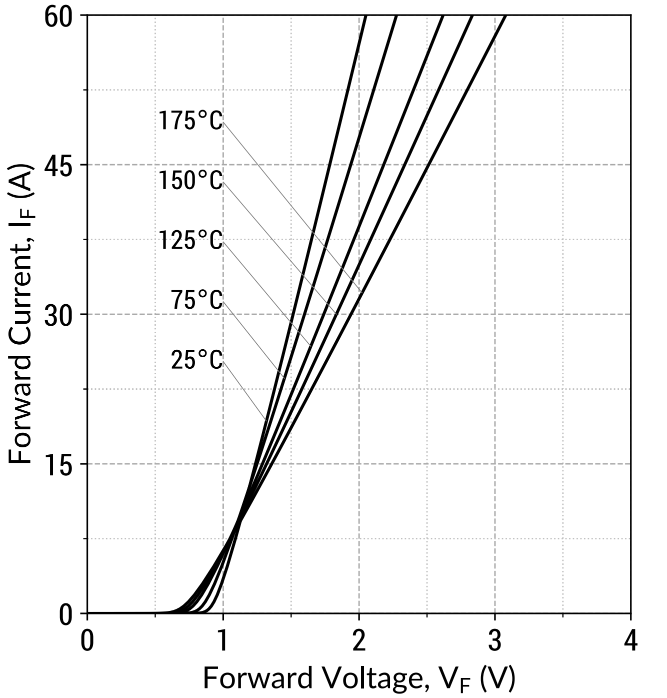
Electrical Characteristics

Parameter	Symbol	Conditions		Values Min.	Values Typ.	Values Max.	Unit	Note
Diode Forward Voltage	V_F	I_F = 30 A, T_j = 25°C			1.5	1.8	V	Fig. 1
		I_F = 30 A, T_j = 175°C			1.9			
Reverse Current	I_R	V_R = 1200 V, T_j = 25°C			2	20	μA	Fig. 2
		V_R = 1200 V, T_j = 175°C			20			
Total Capacitive Charge	Q_C	$I_F \le I_{F,MAX}$ dI_F/dt = 200 A/μs	V_R = 400 V		67		nC	Fig. 7
			V_R = 800 V		97			
Switching Time	t_S		V_R = 400 V V_R = 800 V		< 10		ns	
Total Capacitance	C	V_R = 1 V, f = 1MHz			1101		pF	Fig. 6
		V_R = 800 V, f = 1MHz			64			

Mechanical Parameters

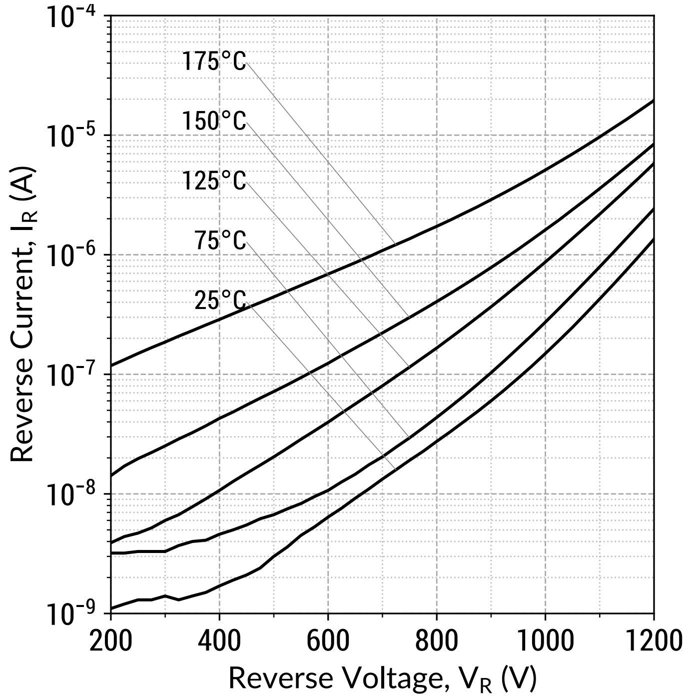
This information is confidential, please contact **sales@genesicsemi.com** to learn more.

Figure 1: Typical Forward Characteristics



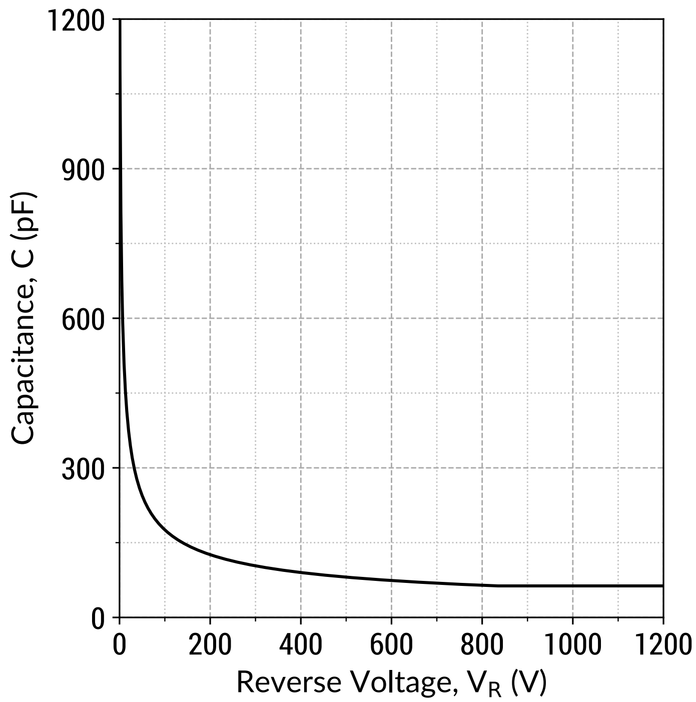
$I_F = f(V_F, T_j)$; $t_P = 250$ µs

Figure 2: Typical Reverse Characteristics



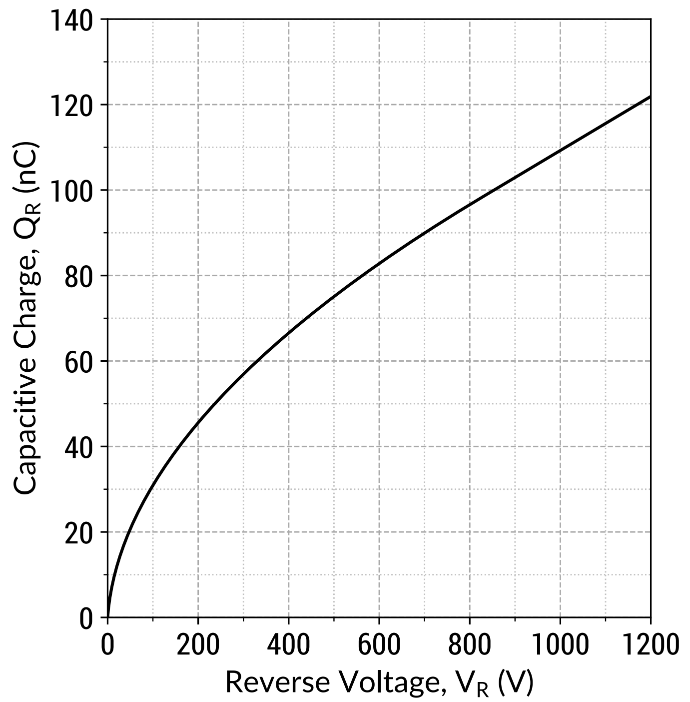
$I_R = f(V_R, T_j)$

Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics



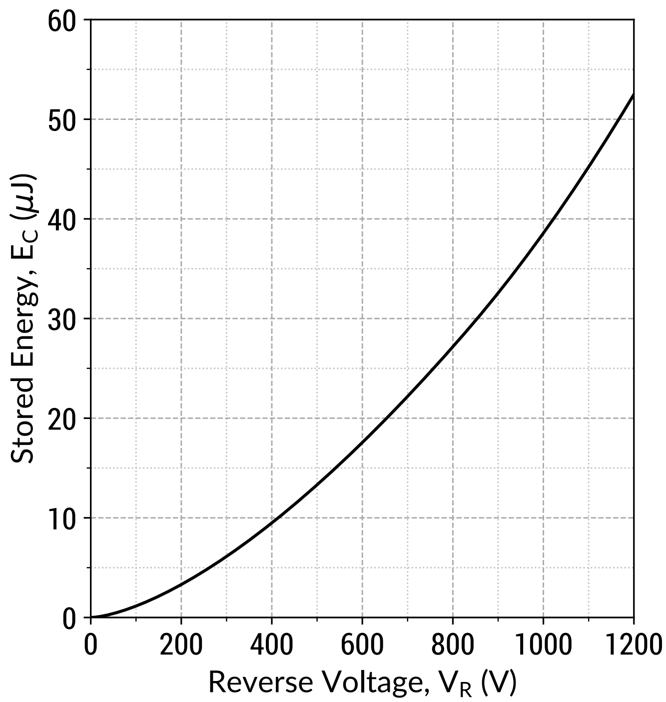
$C = f(V_R)$; f = 1MHz

Figure 4: Typical Capacitive Charge vs Reverse Voltage Characteristics



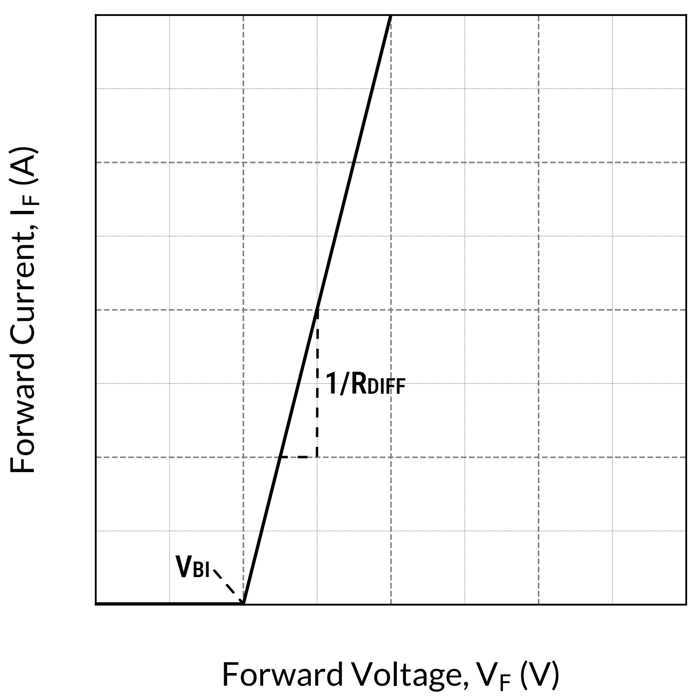
$Q_C = f(V_R)$; f = 1MHz

Figure 5: Typical Capacitive Energy vs Reverse Voltage Characteristics



$E_C = f(V_R)$; f = 1MHz

Figure 6: Forward Curve Model



$I_F = f(V_F, T_j)$

Forward Curve Model Equation:

$I_F = (V_F - V_{BI})/R_{DIFF}$ (A)

Built-In Voltage (V_{BI}):

$V_{BI}(T_j) = m \times T_j + n$ (V)

m = -0.00119 (V/°C)

n = 1.01 (V)

Differential Resistance (R_{DIFF}):

$R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c$ (Ω)

a = 3.97e-07 (Ω/°C²)

b = 5.5e-05 (Ω/°C)

c = 0.0163 (Ω)

Forward Power Loss Equation:

$P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$

Chip Dimensions

This information is confidential, please contact **sales@genesicsemi.com** to learn more.

NOTE

1. CONTROLLED DIMENSION IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.

Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

Disclaimer

GeneSiC Semiconductor, Inc. reserves right to make changes to the product specifications and data in this document without notice. GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

Unless otherwise expressly indicated, GeneSiC products are not designed, tested or authorized for use in life-saving, medical, aircraft navigation, communication, air traffic control and weapons systems, nor in applications where their failure may result in death, personal injury and/or property damage.

Related Links

- SPICE Models: https://www.genesicsemi.com/sic-schottky-mps/GD30MPS12-CAL/GD30MPS12-CAL_SPICE.zip
- PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GD30MPS12-CAL/GD30MPS12-CAL_PLECS.zip
- CAD Models: https://www.genesicsemi.com/sic-schottky-mps/GD30MPS12-CAL/GD30MPS12-CAL_3D.zip
- Evaluation Boards: https://www.genesicsemi.com/technical-support
- Reliability: https://www.genesicsemi.com/reliability
- Compliance: https://www.genesicsemi.com/compliance
- Quality Manual: https://www.genesicsemi.com/quality

Revision History

- Rev 21/Jun: Updated with most recent test data
- Supersedes: Rev 20/Jul

www.genesicsemi.com/sic-schottky-mps/

Published by GeneSiC Semiconductor, Inc.
43670 Trade Center Place Suite 155, Dulles, VA 20166; USA